

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
30052055	01/17/2002	257	5/	2019 3811	Pert
APPLICANTS: Grover Jason; Coss Elfidio; Conboy Michael; Allen Sam <i>W, M 700/121 - clamp</i>					
CONTINUING DATA VERIFIED:					
FOREIGN APPLICATIONS VERIFIED:					
PG-PUB	DO NOT PUBLISH <input checked="" type="checkbox"/>	RESCIND <input type="checkbox"/>	ATTORNEY DOCKET NO		
Foreign priority claimed		<input type="checkbox"/> yes <input type="checkbox"/> no	2000.0087200/TJ4578		
35 USC 119 conditions met		<input type="checkbox"/> yes <input type="checkbox"/> no			
Verified and Acknowledged Examiners initials					
TITLE : Determining a possible cause of a fault in a semiconductor-fabrication process					
U.S. DEPT. OF COMM/PAT & TM-PTO-435L (Rev. 12-94)					